

## 25W Power Packaged Transistor

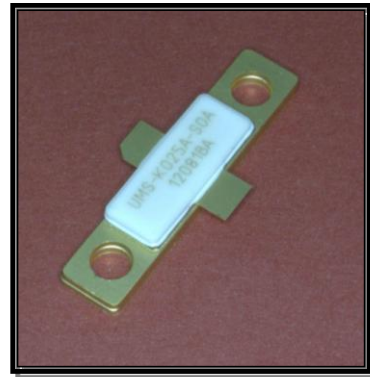
### GaN HEMT on SiC

#### Description

The CHK025A-SOA is an unmatched packaged Gallium Nitride High Electron Mobility Transistor. It offers general purpose and broadband solutions for a variety of RF power applications. It is well suited for multi-purpose applications such as radar and telecommunication.

The CHK025A-SOA is developed on a 0.5 $\mu$ m gate length GaN HEMT process. It requires an external matching circuitry.

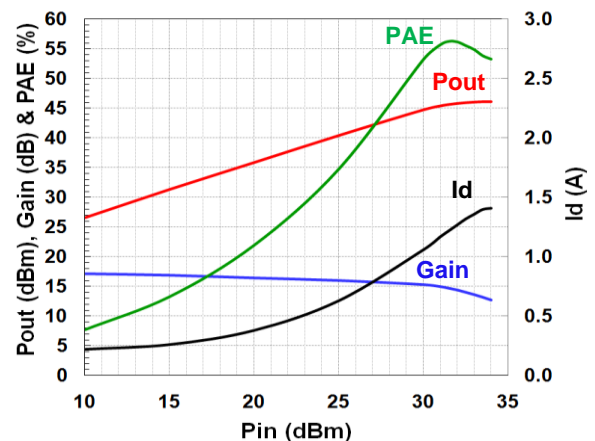
The CHK025A-SOA is available as a ceramic-metal flange power package providing low parasitic and low thermal resistance.



#### Main Features

- Wide band capability: up to 5GHz
- Pulsed and CW operating modes
- High power: > 25W
- High Efficiency: up to 70%
- DC bias:  $V_{DS} = 50V$  @  $I_{D,Q} = 200mA$
- MTTF >  $10^6$  hours @  $T_j = 200^\circ C$
- RoHS Flange Ceramic package

$V_{DS} = 50V$ ,  $I_{D,Q} = 200mA$ , Freq=4GHz  
Pulsed mode



Intrinsic performances of the packaged device

#### Main Electrical Characteristics

$T_{case} = +25^\circ C$ , Pulsed mode,  $F = 4GHz$ ,  $V_{DS} = 50V$ ,  $I_{D,Q} = 200mA$

Symbol	Parameter	Min	Typ	Max	Unit
$G_{SS}$	Small Signal Gain	15	17		dB
$P_{SAT}$	Saturated Output Power	30	38		W
PAE	Max Power Added Efficiency	55	60		%
$G_{PAE\_MAX}$	Associated Gain at Max PAE		13		dB

**Recommended DC Operating Ratings**T<sub>case</sub>= +25°C

Symbol	Parameter	Min	Typ	Max	Unit	Conditions
V <sub>DS</sub>	Drain to Source Voltage	20		50	V	
V <sub>GS_Q</sub>	Gate to Source Voltage		-1.9		V	V <sub>D</sub> =50V, I <sub>D_Q</sub> =200mA
I <sub>D_Q</sub>	Quiescent Drain Current		0.2	0.65	A	V <sub>D</sub> =50V
I <sub>D_MAX</sub>	Drain Current		1.3	<sup>(1)</sup>	A	V <sub>D</sub> =50V, Compressed mode
I <sub>G_MAX</sub>	Gate Current (forward mode)		0	16	mA	Compressed mode
T <sub>J_MAX</sub>	Junction temperature			200	°C	

<sup>(1)</sup> Limited by dissipated power**DC Characteristics**T<sub>case</sub>= +25°C

Symbol	Parameter	Min	Typ	Max	Unit	Conditions
V <sub>P</sub>	Pinch-Off Voltage	-3	-2	-1	V	V <sub>D</sub> =50V, I <sub>D</sub> = I <sub>DSS</sub> /100
I <sub>D_SAT</sub>	Saturated Drain Current		5.4 <sup>(1)</sup>		A	V <sub>D</sub> =7V, V <sub>G</sub> =2V
I <sub>G_leak</sub>	Gate Leakage Current (reverse mode)	-2			mA	V <sub>D</sub> =50V, V <sub>G</sub> =-7V
V <sub>BDS</sub>	Drain-Source Break-down Voltage		200		V	V <sub>G</sub> =-7V, I <sub>D</sub> =20mA
R <sub>TH</sub>	Thermal Resistance		3.7		°C/W	

<sup>(1)</sup> For information, limited by I<sub>D\_MAX</sub>, see on Absolute Maximum Ratings**RF Characteristics (CW)**T<sub>case</sub>= +25°C, CW mode, F = 4GHz, V<sub>DS</sub>=50V, I<sub>D\_Q</sub>=200mA

Symbol	Parameter	Min	Typ	Max	Unit
G <sub>SS</sub>	Small Signal Gain	14	16	-	dB
P <sub>SAT</sub>	Saturated Output Power	28	35	-	W
PAE	Max Power Added Efficiency	50	55	-	%
G <sub>PAE_MAX</sub>	Associated Gain at Max PAE		12	-	dB

**RF Characteristics (Pulsed)**T<sub>case</sub>= +25°C, Pulse mode <sup>(1)</sup>, F = 4GHz, V<sub>DS</sub>=50V, I<sub>D\_Q</sub>=200mA

Symbol	Parameter	Min	Typ	Max	Unit
G <sub>SS</sub>	Small Signal Gain	15	17		dB
P <sub>SAT</sub>	Saturated Output Power	30	38		W
PAE	Max Power Added Efficiency	55	60		%
G <sub>PAE_MAX</sub>	Associated Gain at Max PAE		13		dB

<sup>(1)</sup> Input RF and gate voltage are pulsed. Conditions are 25µs width, 10% duty cycle and 1µs offset between RF and DC pulse.

These values are the intrinsic performance of the packaged device. They are deduced from measurements and simulations. They are considered in the reference plane defined by the leads of the package, at the connection interface with the PCB.

The typical performance achievable in more than 20% frequency band around 4GHz was demonstrated using the reference board 61500252 presented hereafter.

**Absolute Maximum Ratings <sup>(1)</sup>**T<sub>case</sub>= +25°C<sup>(1), (2), (3)</sup>

Symbol	Parameter	Rating	Unit	Note
V <sub>DS</sub>	Drain-Source Voltage	60	V	
V <sub>GS_Q</sub>	Gate-Source Voltage	-10, +2	V	<sup>(6)</sup>
I <sub>G_MAX</sub>	Maximum Gate Current in forward mode	48	mA	
I <sub>G_MIN</sub>	Maximum Gate Current in reverse mode	-8	mA	
I <sub>D_MAX</sub>	Maximum Drain Current	4	A	<sup>(4)</sup>
P <sub>IN</sub>	Maximum Input Power (typical)	37	dBm	<sup>(5)</sup>
T <sub>j</sub>	Junction Temperature	220	°C	
T <sub>STG</sub>	Storage Temperature	-55 to +150	°C	
T <sub>Case</sub>	Case Operating Temperature	See note	°C	<sup>(4)</sup>

<sup>(1)</sup> Operation of this device above anyone of these parameters may cause permanent damage.

<sup>(2)</sup> Duration < 1s.

<sup>(3)</sup> The given values must not be exceeded at the same time even momentarily for any parameter, since each parameter is independent from each other, otherwise deterioration or destruction of the device may take place.

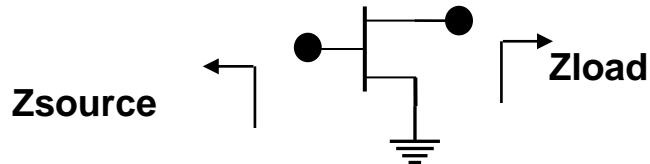
<sup>(4)</sup> Max junction temperature must be considered

<sup>(5)</sup> @4GHz -Linked to and limited by I<sub>G\_MAX</sub> & I<sub>G\_MIN</sub> values

<sup>(6)</sup> V<sub>GS\_Q</sub> max limited by I<sub>D\_MAX</sub> and I<sub>G\_MAX</sub> values

## Simulated Source and Load Impedance

$V_{DS} = 50V$ ,  $I_{D_Q} = 200mA$



Frequency (MHz)	Source	Load
1000	$4.3 + j4$	$10.9 + j22.45$
2000	$1.5 - j1.5$	$7.2 + j10.7$
3000	$2.7 - j4.65$	$4.8 + j1.01$
4000	$3.9 - j8.6$	$4.27 - j0.38$
4500	$6.4 - j11$	$3.44 - j1.87$
5000	$7.8 - j3.2$	$2.5 - j3.8$

These values are given in the reference plane defined by the connection between the package leads and the PCB. A gap of 200 $\mu$ m is considered between the edge of the package and the PCB.

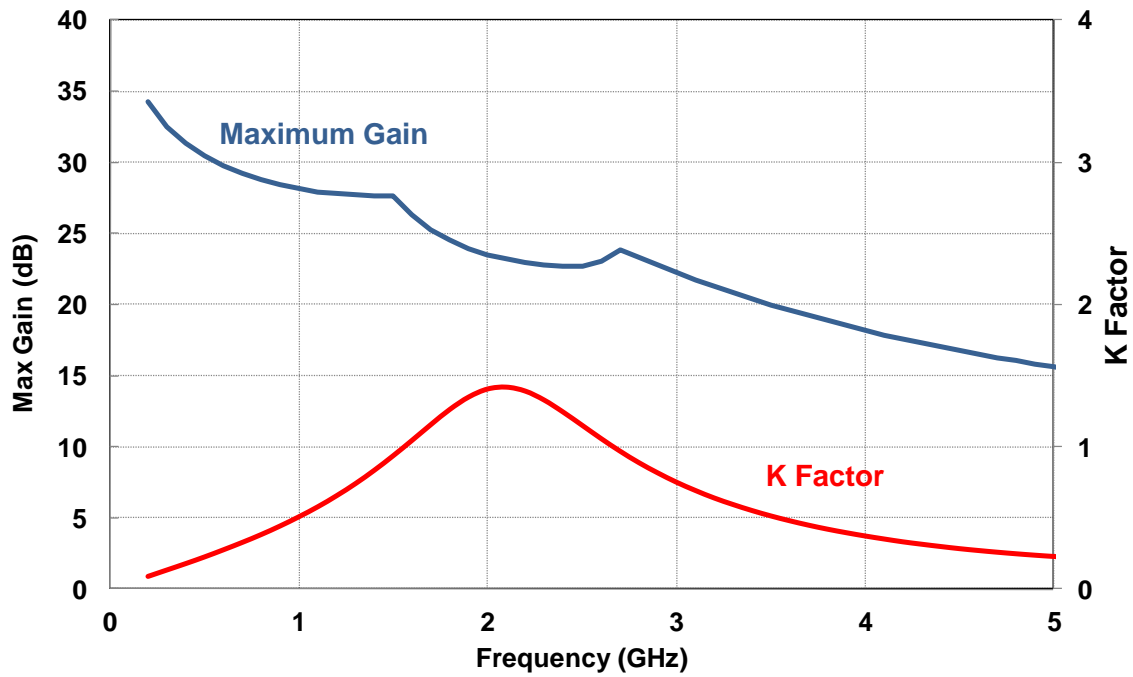
## Typical S-parameters

T<sub>case</sub>= +25°C, CW mode, V<sub>D</sub>=50V, I<sub>D\_Q</sub>=200mA, Phase S(i,j) in °

Freq (GHz)	Mag S(1,1)	Phase S(1,1)	Mag S(2,1)	Phase S(2,1)	Mag S(1,2)	Phase S(1,2)	Mag S(2,2)	Phase S(2,2)
0.25	0.886	-129.437	30.314	104.238	0.014	17.910	0.389	-86.172
0.50	0.875	-154.667	15.860	83.192	0.014	0.651	0.390	-106.758
0.75	0.879	-164.613	10.371	69.970	0.013	-8.091	0.452	-117.153
1.00	0.887	-170.456	7.503	59.368	0.011	-13.026	0.522	-125.117
1.25	0.895	-174.726	5.748	50.243	0.010	-14.452	0.587	-132.020
1.50	0.903	-178.272	4.575	42.177	0.008	-11.379	0.644	-138.196
1.75	0.911	178.557	3.746	34.942	0.007	-2.075	0.691	-143.771
2.00	0.917	175.594	3.138	28.383	0.006	13.981	0.730	-148.834
2.25	0.921	172.749	2.680	22.377	0.006	32.012	0.762	-153.458
2.50	0.925	169.964	2.329	16.821	0.007	45.433	0.788	-157.712
2.75	0.928	167.201	2.055	11.629	0.009	53.094	0.809	-161.656
3.00	0.929	164.426	1.839	6.728	0.011	56.772	0.826	-165.344
3.25	0.930	161.611	1.666	2.053	0.013	58.056	0.840	-168.822
3.50	0.930	158.728	1.529	-2.453	0.015	57.905	0.852	-172.133
3.75	0.930	155.747	1.419	-6.843	0.018	56.856	0.861	-175.311
4.00	0.928	152.639	1.331	-11.165	0.020	55.212	0.868	-178.391
4.25	0.926	149.371	1.262	-15.466	0.023	53.147	0.874	178.597
4.50	0.923	145.903	1.209	-19.792	0.025	50.758	0.878	175.626
4.75	0.919	142.192	1.169	-24.190	0.028	48.095	0.881	172.669
5.00	0.914	138.185	1.142	-28.711	0.031	45.179	0.883	169.699
5.25	0.909	133.819	1.126	-33.409	0.035	42.006	0.884	166.688
5.50	0.901	129.016	1.120	-38.343	0.038	38.553	0.884	163.608
5.75	0.893	123.683	1.125	-43.583	0.042	34.782	0.883	160.426
6.00	0.883	117.703	1.140	-49.205	0.047	30.634	0.881	157.107
6.25	0.871	110.934	1.166	-55.300	0.052	26.035	0.879	153.606
6.50	0.856	103.202	1.202	-61.972	0.058	20.892	0.876	149.873
6.75	0.840	94.296	1.249	-69.338	0.064	15.089	0.873	145.839
7.00	0.821	83.976	1.305	-77.527	0.071	8.501	0.869	141.418
7.25	0.801	71.985	1.369	-86.673	0.079	0.987	0.865	136.486
7.50	0.781	58.096	1.439	-96.903	0.087	-7.587	0.861	130.871
7.75	0.764	42.204	1.509	-108.312	0.096	-17.331	0.858	124.332
8.00	0.753	24.459	1.572	-120.946	0.105	-28.309	0.854	116.539
8.25	0.753	5.387	1.620	-134.786	0.113	-40.525	0.850	107.059
8.50	0.766	-14.137	1.644	-149.757	0.119	-53.936	0.844	95.370
8.75	0.791	-33.132	1.637	-165.763	0.123	-68.479	0.835	80.892
9.00	0.825	-50.842	1.592	177.304	0.125	-84.093	0.822	63.091
9.25	0.862	-66.886	1.504	159.605	0.122	-100.664	0.809	41.721
9.50	0.897	-81.185	1.372	141.482	0.115	-117.910	0.801	17.258
9.75	0.926	-93.780	1.202	123.552	0.105	-135.283	0.804	-8.747
10.00	0.946	-104.730	1.013	106.595	0.092	-152.073	0.819	-34.034

**Maximum Gain & Stability Characteristics**

T<sub>case</sub>= +25°C, CW mode, V<sub>D</sub>=50V, I<sub>D\_Q</sub>=200mA

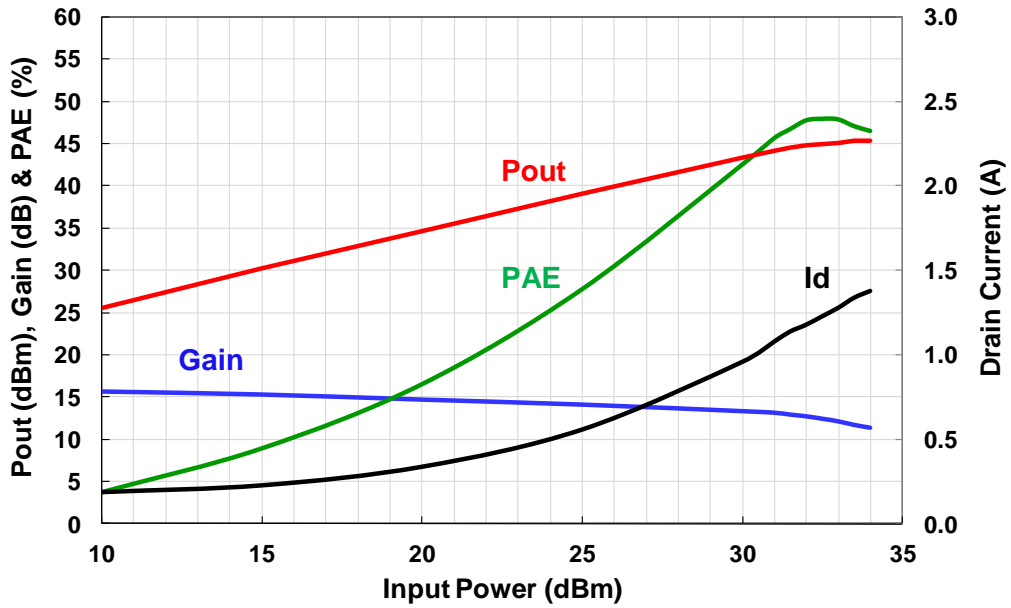


Typical Performance on Demonstration Board (Ref. 61500252)

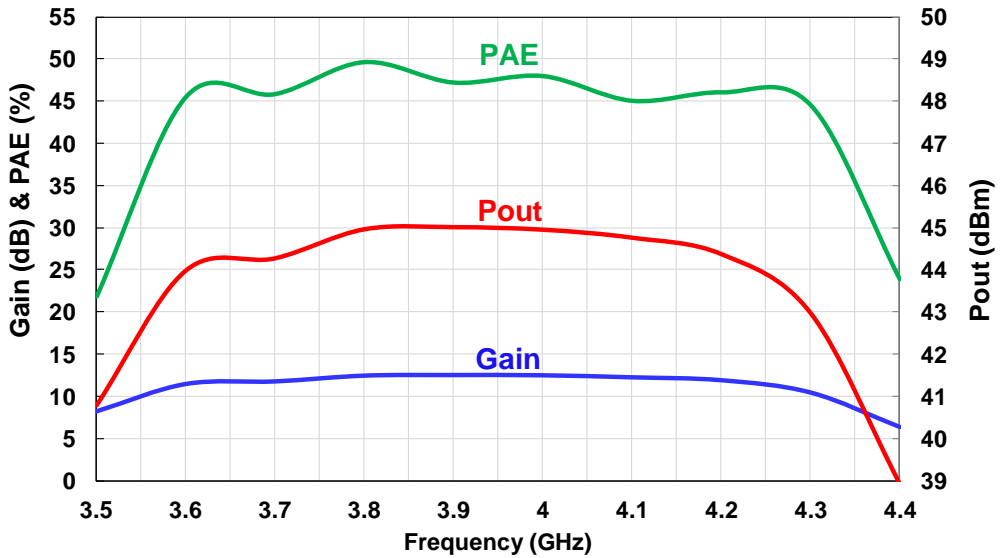
Calibration and measurements are done on the connector reference accesses of the demonstration boards.

T<sub>case</sub> = +25°C, CW mode

Measured Pout, Gain, PAE & Id  
 F = 4GHz, V<sub>DS</sub> = 50V, I<sub>D,Q</sub> = 200mA



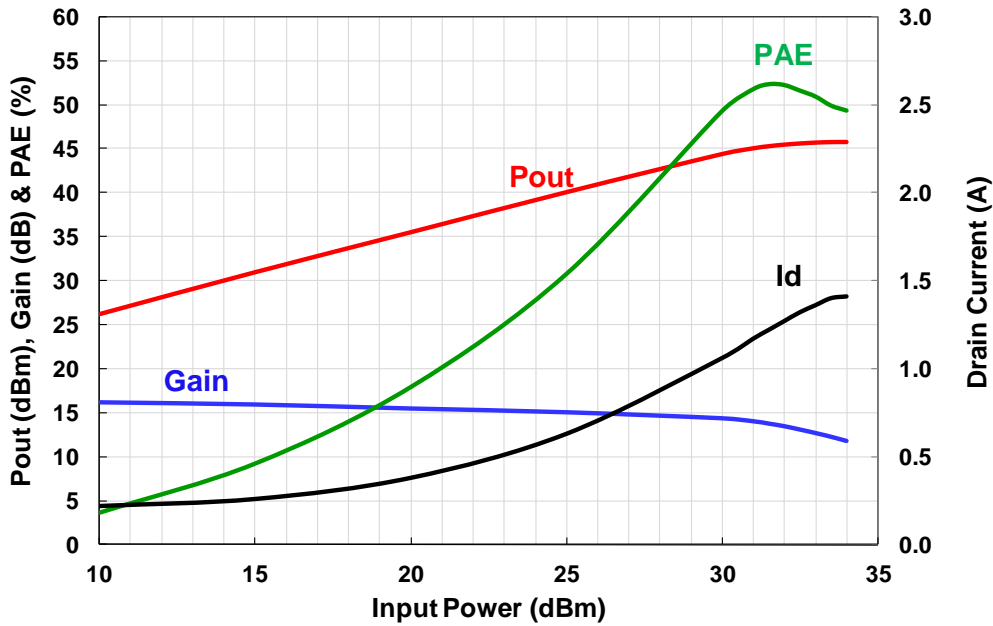
Measured Pout, PAE & Gain  
 Pin = 32.5 dBm, V<sub>DS</sub> = 50V, I<sub>D,Q</sub> = 200mA



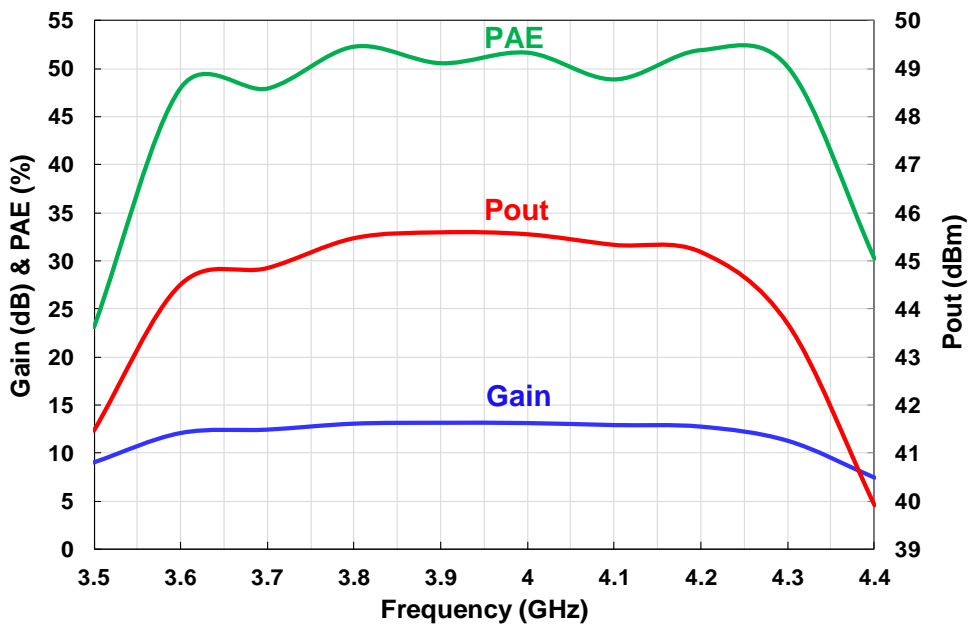
Typical Performance on Demonstration Board (Ref. 61500252)

Calibration and measurements are done on the connector reference accesses of the demonstration boards.

**T<sub>case</sub> = +25°C, Pulsed mode <sup>(1)</sup>**  
 Measured P<sub>out</sub>, Gain, PAE & I<sub>d</sub>  
 F = 4GHz, V<sub>DS</sub> = 50V, I<sub>D,Q</sub> = 200mA



Measured P<sub>out</sub>, PAE & Gain  
 P<sub>in</sub> = 32.5 dBm, V<sub>DS</sub> = 50V, I<sub>D,Q</sub> = 200mA



<sup>(1)</sup> Input RF and gate voltage are pulsed. Conditions are 25µs width, 10% duty cycle and 1µs offset between RF and DC pulse.



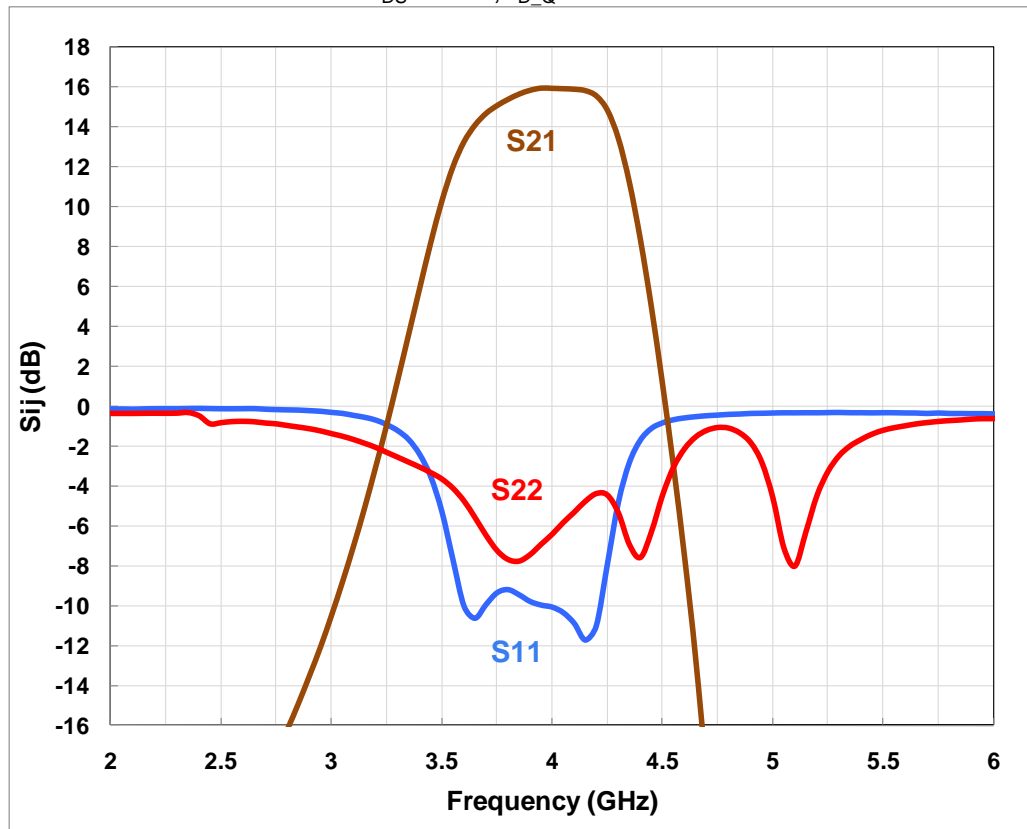
**Typical Performance on Demonstration Board (Ref. 61500252)**

Calibration and measurements are done on the connector reference accesses of the demonstration boards

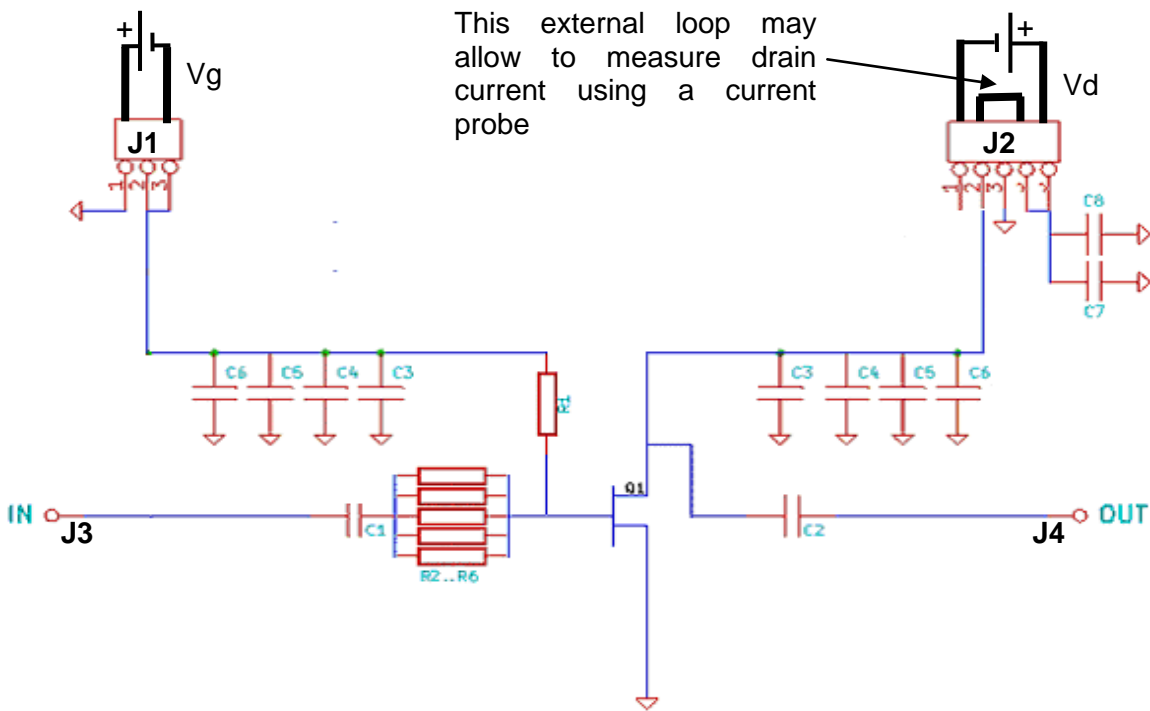
**T<sub>case</sub> = +25°C, CW mode**

Measured S parameters

V<sub>DS</sub> = 50V, I<sub>D\_Q</sub> = 200mA



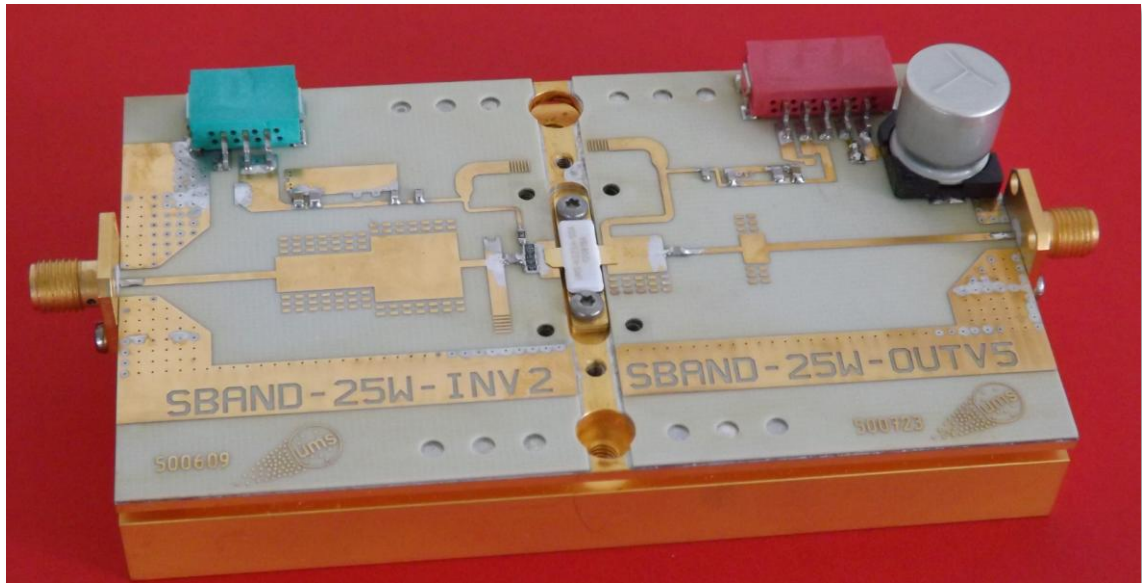
**Demonstration Amplifier Low Frequency Equivalent Schematic (Ref. 61500252)**



**Demonstration Amplifier (Ref. 61500252) / Bill of Materials**

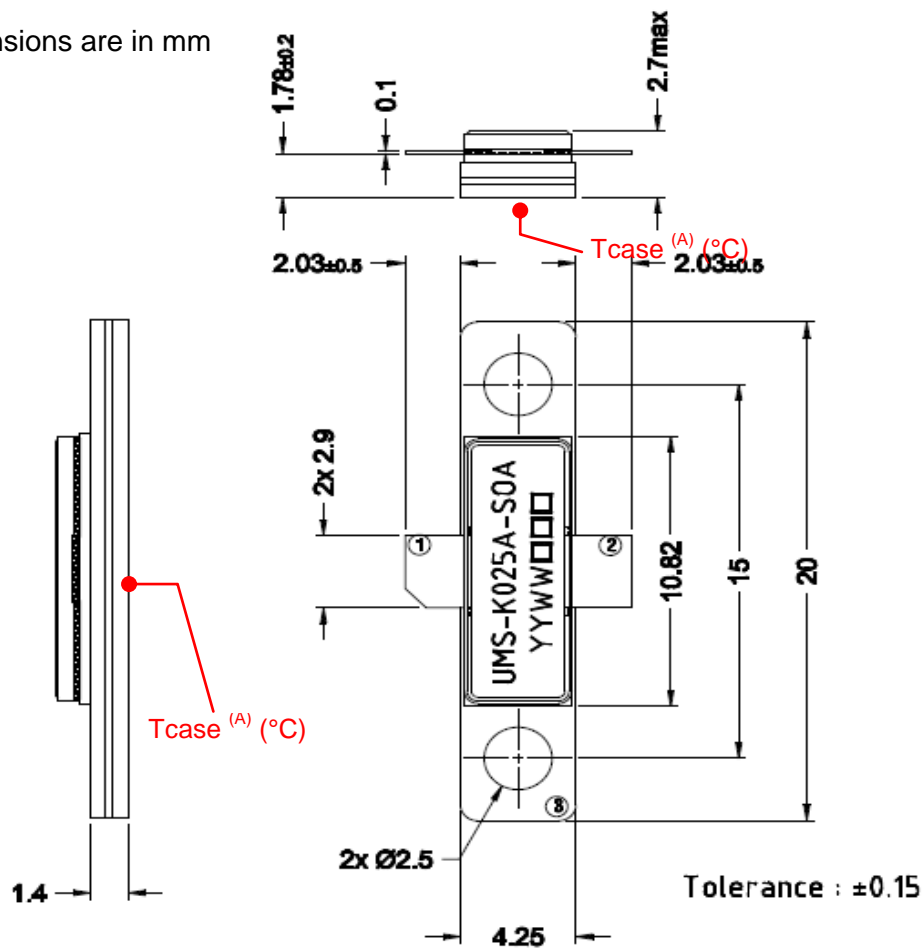
Designator	Type	Value - Description	Qty
C1	Capacitor	0.4pF, +/- 0.05pF, 0603	1
C2	Capacitor	0.6pF, +/- 0.05pF, 0603	1
C3	Capacitor	8.2pF, +/- 0.25%, 0603	2
C4	Capacitor	82pF, +/- 5%, 0603	2
C5	Capacitor	1nF, +/- 5%, 0805	2
C6	Capacitor	10nF, +/- 5%, 0805	2
C7	Capacitor	1µF, +/- 10%, 1204	1
C8	Capacitor	68µF, +/- 10%, 1204	1
R1	Resistor	147Ω, +/- 1%, 0603	1
R2..R6	Resistor	5,6Ω +/- 1%, 0603	5
J1	Connector	CMS 3cts	1
J2	Connector	CMS 5cts	1
J3,J4	Connector	SMA	2
Q1	Packaged Transistor	CHK025A-SOA	1
-	PCB	RO4003, Er=3.55, h= 508µm	-

**Demonstration Amplifier Circuit (Ref. 61500252)**



## Package outline

All dimensions are in mm



**PIN-OUT :** 1- GATE  
2- DRAIN  
3- SOURCE (Gnd)

<sup>(A)</sup> Tcase locates the reference point used to monitor the device temperature. This point has been taken at the device / system interface to ease system thermal design. Chamfered lead indicates the gate access of the packaged transistor.

## Recommended Assembly Procedure

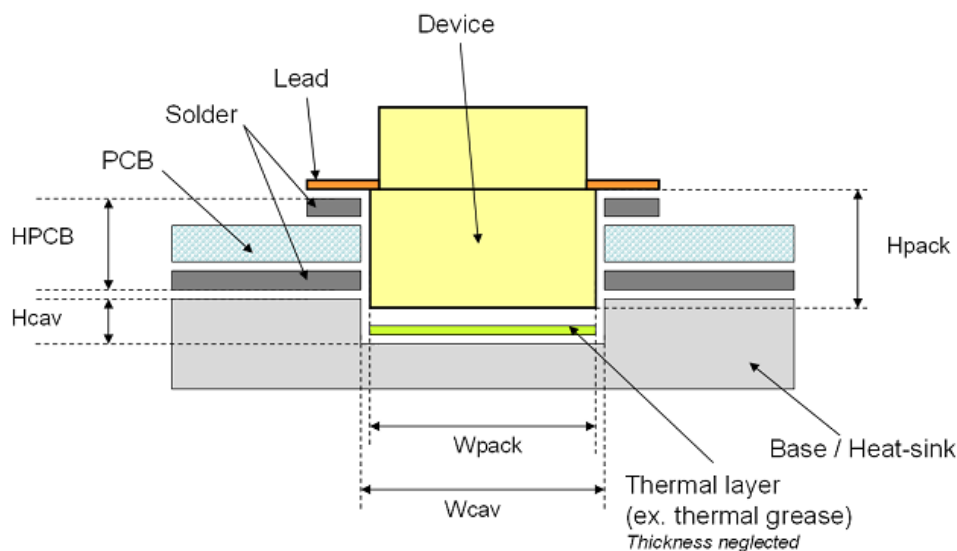
CHK025A-SOA is available has a flange package to be bolt down onto a thermal heat sink also used as main electrical ground. Use preferably screw M2 and flat washers.

Thermal and electrical resistance at the package to heat sink interface has to be as low as possible. Thermal electrically conductive grease or conductive thin layer like indium sheets are recommended between the package and the heat sink.

In case a thermal grease is selected, we recommend to use material offering thermal conductivity  $>5\text{W/m.K}$  and electrical resistivity  $<0.01\text{ ohm.cm}$ . The grease layer thickness should be about  $25\mu\text{m}$  (1 mil).

Contact interface quality can be improved by cleaning process prior device mounting on the heat-sink. Such operation will enhance the thermal and electrical contact by oxides removal at each interface.

Package leads can be soldered on printed circuit board's traces by using RoHS solder past. Cavity depth and width to be performed into the heat-sink where the device will be mounted are important to achieve the best performances. These dimensions have to be optimized in order to minimize the distance between device and signal traces made on the printed circuit board (PCB). But they also have to be calculated in order to accommodate device variations in height. The following drawing gives the relationship between device dimensions ( $H_{\text{pack}}$  &  $W_{\text{pack}}$ ) and optimal cavity depth ( $H_{\text{cav}}$ ) and width ( $W_{\text{cav}}$ ) depending on the printed circuit-board configuration (HPCB)



$$H_{\text{cav}} = (H_{\text{pack}_{\text{min}}} - H_{\text{PCB}_{\text{max}}})^{+0}_{-0.05}$$

$$W_{\text{cav}} = (W_{\text{pack}_{\text{max}}} + 0.4) \pm 0.05$$

dimensions are in mm

## Recommended environmental management

UMS products are compliant with the regulation in particular with the directives RoHS N°2011/65 and REACH N°1907/2006. More environmental data are available in the application note AN0019 also available at <http://www.ums-gaas.com>.

## Recommended ESD management

Refer to the application note AN0020 available at <http://www.ums-gaas.com> for ESD sensitivity and handling recommendations for the UMS package products.

## Ordering Information

Package: CHK025A-SOA/XY  
Tray: XY = 26

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